

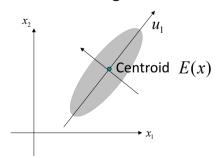
Lecture 11: Dimensionality Reduction and Subspace-based Methods DD2421

Atsuto Maki

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Principal Component Analysis (PCA)

1. Maximizing variance



/Number of samples

Mean vector of x:

$$E(x) = (1/r)\sum_{r=0}^{\infty} x^{r}$$

Covariance matrix: $\Sigma = E((x - E(x))(x - E(x))^T)$

Our keywords today:

- Dimensionality reduction
 - Principal Component Analysis (PCA)
- Discriminant function
 - Similarity measures: angle, projection length
- Subspace Methods

1. Maximum variance criterion

Reduce the effective number of variables (only dealing with components with larger variances)

$$E((x^{T}u_{i} - E(x^{T}u_{i}))^{2}) \rightarrow \text{Maximize} \quad (i = 1,..., p)$$

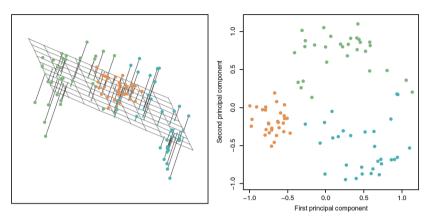
$$= E((u_{i}^{T}(x - E(x)))^{2})$$

$$= u_{i}^{T} \underbrace{E((x - E(x))(x - E(x))^{T})}_{\text{Covariance matrix}} u_{i} = u_{i}^{T} \Sigma u_{i} \qquad u_{i}^{T} u_{j} = \delta_{ij}$$

$$\text{max}[\text{tr}(U^{T} \Sigma U)]$$

The transformation matrix U consists of p columns: the eigenvectors of the covariance matrix, Σ (corresponding to its p largest eigenvalues).

Example 3-d to 2-d: Ninety observations simulated in 3-d

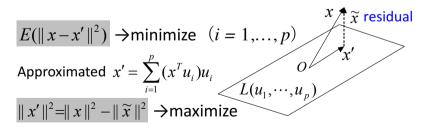


The first 2 principal component directions span the plane that best fits the data. It minimizes the sum of squared distances from each point to the plane.

Figure from
An Introduction to Statistical Learning (James et al.)

2. Minimum squared distance criterion

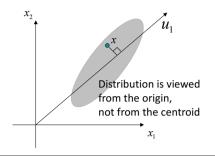
Averaged squared error between x and its approximation to be minimized by a set $\{u_1, \dots, u_p\}$



The basis consists of p eigenvectors of the autocorrelation matrix, Q (corresponding to its p largest eigenvalues).

Principal Component Analysis (PCA)

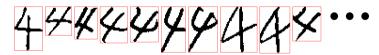
2. Min. approximation error



Autocorrelation matrix:

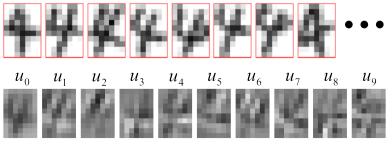
$$Q = E(xx^T)$$

PCA example 1: Hand-written digits



Feature extraction

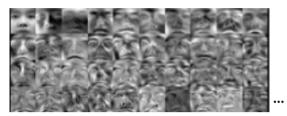
Pattern vectors: normalized & blurred patterns



(figure credit: Y.

Example 2: Human face classification

Basis vectors of a person: someone's dictionary



(Eigenvectors from a large collection of his/her face)

(figure credit: K. Fukui)

Concept of subspace

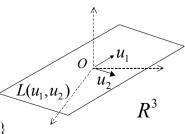
Subspace L is a collection of n-d vectors: spanned by a basis, a set of linearly independent vectors

$$L(b_1, \dots, b_p) = \{z \mid z = \sum_{i=1}^p \xi_i b_i\}$$
 $(\xi_i \in R, b_i \in R^n)$

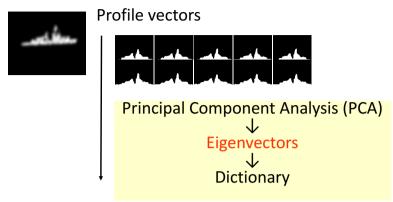
Dimension of a subspace: the number of base vectors

$$p = \dim(L) \ll n$$

Conveniently represented by orthonormal basis $\{u_1, \dots, u_n\}$



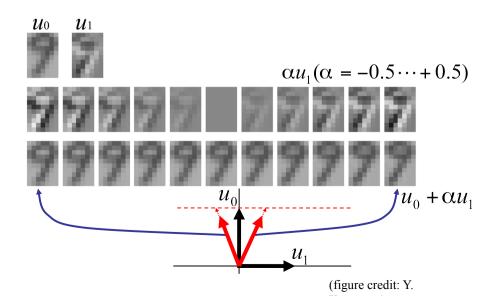
Example 3: Ship classification (profiles)



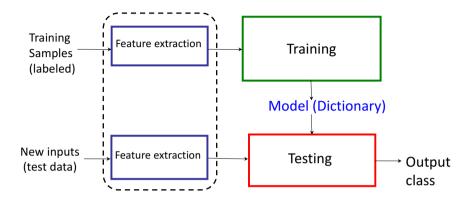
Eigenvectors for the greatest eigenvalues



• Variations of "9" covered by a 2-d subspace



Background: Schematic of classification



Testing phase

- Various ways to measure the distance
 - Euclidean / Mahalanobis distance
 - Angle between vectors
 - Projection length on subspaces

...

- Classification methods
 - Discriminant function
 - Subspace method

...

Training phase

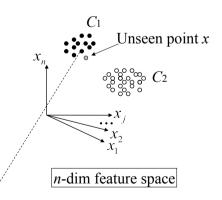
- Given: Limited number of labeled data (samples whose classes are known)
- The dimensionality often too high for limited number of samples

One approach to this is to find redundant variables and discard them, i.e. dimensionality reduction (without losing essential information)

Information compression: to extract the class characteristics and throw away the rest!

Nearest Neighbor methods (revisiting)

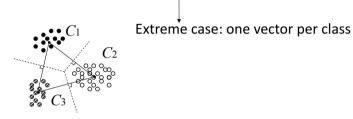
- · Binary classification
 - $-N_1$ samples of class C_1
 - $-N_2$ samples of class C_2
 - Unseen data x
 - → Compute distances to $N_1 + N_2$ samples



- Find the nearest neighbour
- \rightarrow classify x to the same class

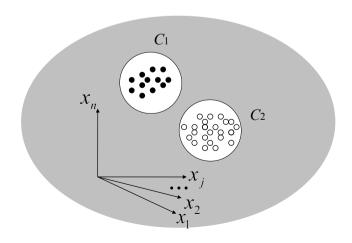
Discriminant function

- Need to remember all the samples?
 - In k-NN we simply used all the training data
 - Still cover only a small portion of possible patterns
- Define a class by a few representative patterns
 - e.g. the centroid of class distribution



Setting the "don't know" category

• Reject if the distance is above the threshold



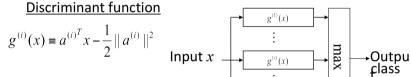
Formulation: one prototype per class

- K classes: $C^{(1)}, \dots, C^{(K)}$

- K prototypes: $a^{(1)}, \dots, a^{(K)}$

Consider Euclidean distances between the new input x and the prototypes: $\|x - a^{(i)}\|^2 = \|x\|^2 - 2a^{(i)^T}x + \|a^{(i)}\|^2$

→ Choose the class that minimises the distance.



Direction cosine as similarity

Think of the new input and the prototype as vectors. Compute cosine between the input vector x and vector $a^{(i)}$

$$g^{(i)}(x) = \frac{(x^T a^{(i)})}{\|x\| \|a^{(i)}\|} = \cos A$$

"Simple similarity"

 $0 \le \cos^2 A \le 1$ (The closer it is to 1, the more likely to be in $C^{(i)}$)

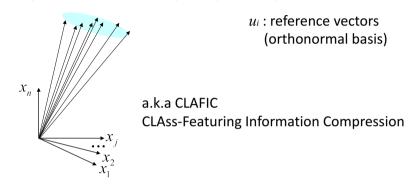
Now let's extend the class representative to a set of basis vectors → spans a subspace

Subspace Methods

• Exploit localization of pattern distributions

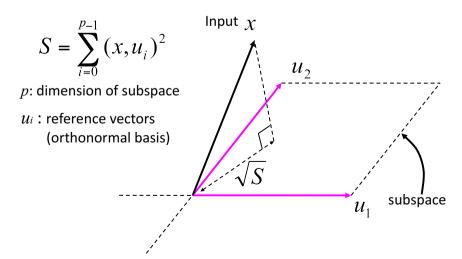
Samples in the same class such as a digit (or face images of a person) are similar to each other.

They are <u>localized</u> in a *subspace* spanned by <u>a set of basis</u> u_i .



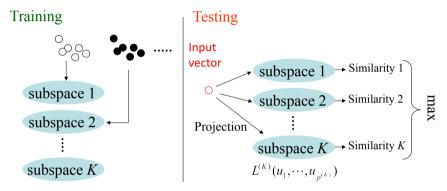
Similarity in Subspace Method

Projection length to the subspace



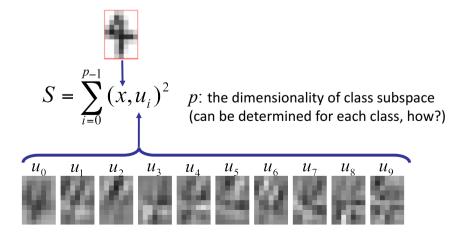
Framework of Subspace Method

- 1. Training: for each class, compute a low-dimensional subspace that represents the distribution in the class. $\omega^{(1)}, \dots, \omega^{(K)}$
- 2. Testing: determine the class of new unknown input by comparing which subspace best approximates the input.



Similarity in Subspace Method (example)

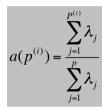
Projection length to the subspace



Dimensionality of a class subspace

Eigenvalues of autocorrelation matrix $Q: \lambda_1 \ge ... \lambda_j ... \ge \lambda_p \ge 0$ The number of dimensions to be used:

- Too low → low capability to represent the class
- Too high → issue of overlapping across classes
- Cumulative contributions



Choose a dimension $p^{(i)}$ for each class $\omega^{(i)}$

$$a(p^{(i)}) \le \kappa \le a(p^{(i)} + 1)$$
 (κ : common value)

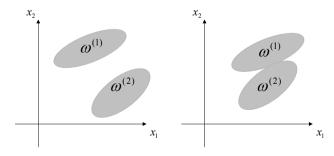
The projection length to the subspace is made uniform.

Experiments still needed to find a good dimensionality

Useful dimension for classification?

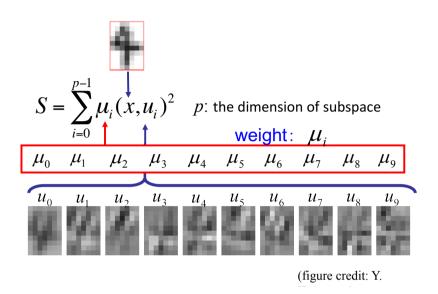
Ideal distributions of input pattern vectors:

- Patterns from an identical class be close
- Patterns from different classes be apart

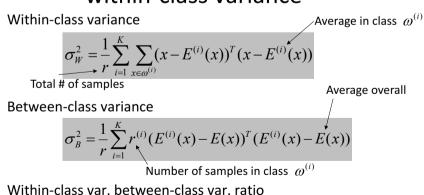


→ Overlapping distributions harmful for classification

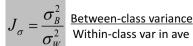
Similarity in weighted Subspace Method



Ratio of between-classes variance to within-class variance



vvitiliii class var. between class var. r



In short: distance between classes normalized by distance within class

→ the larger the better!

Fisher's method

Find a subspace most suitable to classification (discriminant analysis)

Given pattern distributions in 2 classes

 \Rightarrow Optimal axis direction where J is maximized Scatter matrix represents variation within class

$$S_i \equiv \sum_{x \in o^{(i)}} (x - E^{(i)}(x))(x - E^{(i)}(x))^T$$

Within-class:
$$S_W \equiv S_1 + S_2$$
 Between-classes:
$$S_B \equiv \sum_{i=1,2} r^{(i)} (E^{(i)}(x) - E(x)) (E^{(i)}(x) - E(x))^T$$

$$\dots = \frac{r^{(1)} r^{(2)}}{r} (E^{(1)}(x) - E^{(2)}(x)) (E^{(1)}(x) - E^{(2)}(x))^T$$

Fisher's criterion:

$$J_S(A) \equiv \frac{\hat{S}_B}{\hat{S}_W} = \frac{A^T S_B A}{A^T S_W A}$$

Maximizing the ratio of between-classes variance to within-class variance

Lagrange multiplier

$$J(a) \equiv a^{T} S_{B} a - \lambda (a^{T} S_{W} a - I) \Rightarrow \mathsf{Maximize}$$

$$S_{B} a = \lambda S_{W} a \qquad \mathsf{Condition:} \ \hat{S}_{W} = I$$

$$\Leftrightarrow S_{W}^{-1} S_{B} a = \lambda a$$

 $\Leftrightarrow \max\{J_S(a)\} = \lambda_1$ The greatest eigenvalue of $S_W^{-1}S_R$

 \rightarrow The eigenvector for the greatest eigenvalue of $S_w^{-1}S_R$ gives A that maximises Fisher's criterion

From *n*-d feature space to 1-d space by Matrix A A is an $n \times 1$ matrix $\rightarrow n$ -dim vector a in practice

 \rightarrow The pattern will become a scalar by $v = A^T x$

Scatter matrix in the space after the transformation:

$$\hat{S}_{i} = \sum_{x \in \omega^{(i)}} (y - E^{(i)}(y))(y - E^{(i)}(y))^{T}$$

$$= \sum_{y \in \omega^{(i)}} A^{T}(x - E^{(i)}(x))(x - E^{(i)}(x))^{T} A = A^{T} S_{i} A$$

Within-class:
$$\hat{S}_W \equiv \hat{S}_1 + \hat{S}_2 = A^T S_1 A + A^T S_2 A = A^T S_W A$$
Between-class: $\hat{S}_B \equiv \sum_{i=1,2} r^{(i)} (E^{(i)}(y) - E(y))^2$ Scalar
$$\dots = \frac{r^{(1)} r^{(2)}}{r} A^T (E^{(1)}(x) - E^{(2)}(x))^2 A = A^T S_B A$$